


<b>Search Notes</b>  	<b>Application/Control No.</b>  10542329	<b>Applicant(s)/Patent Under Reexamination</b>  SHIMIZU ET AL.
	<b>Examiner</b>  STEPHEN R KOZIOL	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	100, 195	6/5/2009	SRK

SEARCH NOTES		
Search Notes	Date	Examiner
PALM inventor name double patenting search	6/5/2009	SRK
EAST text search of above classes for subpixel image matching comprising determining multi-dimensional image similarity values	6/5/2009	SRK
IEEE explore text search for setting intersection points in an image subsampling grid to provide a maximum or minimum similarity value	6/5/2009	SRK
JPO Patent & Utility Model Gazette DB Abstract search for using similarity values to estimate and display a warped or deformed image	6/5/2009	SRK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	100, 195	6/5/2009	SRK
	EAST PGPub interference search of above classes. See EAST interference report.	6/5/2009	SRK

/STEPHEN R KOZIOL/ Examiner.Art Unit 2624	
--	--